

N-Channel Logic Level Enhancement Mode Field Effect Transistor

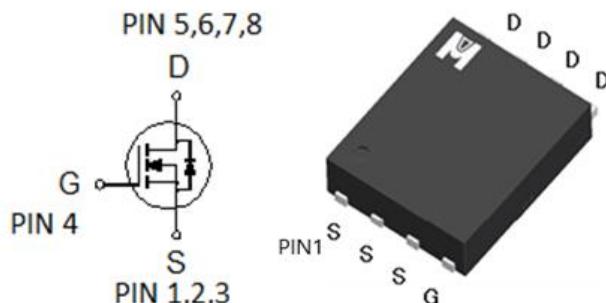
Product Summary:

BV_{DSS}	30V
$R_{DS(on)}$ (MAX.)	$2.1\text{m}\Omega$
I_D	123A

N Channel MOSFET

UIS, R_g 100% Tested

RoHS & Halogen Free & TSCA Compliant



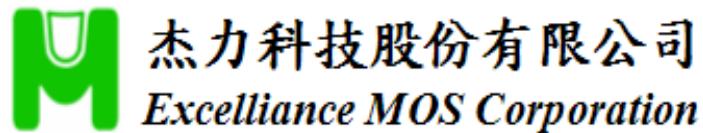
ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNIT
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹	I_D	123	A
		43	
		27	
		78	
Pulsed Drain Current ²	I_{DM}	400	
Avalanche Current	I_{AS}	65	
Avalanche Energy	E_{AS}	211	mJ
Repetitive Avalanche Energy ³	E_{AR}	105	
Power Dissipation	P_D	50	W
		20	
Operating Junction & Storage Temperature Range	T_j, T_{stg}	-55 to 150	°C

100% UIS testing in condition of $V_D=25\text{V}$, $L=0.1\text{mH}$, $V_G=10\text{V}$, $I_L=40\text{A}$, Rated $V_{DS}=30\text{V}$ N-CH

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case		$R_{\theta JC}$	$^{\circ}\text{C}/\text{W}$	2.5	$^{\circ}\text{C}/\text{W}$
Junction-to-Ambient ³	$t \leq 10\text{s}$	$R_{\theta JA}$		20	
Junction-to-Ambient ³	Steady-State	$R_{\theta JA}$		50	



EMP21N03HC

¹Pulse width limited by maximum junction temperature.

²Duty cycle < 1%

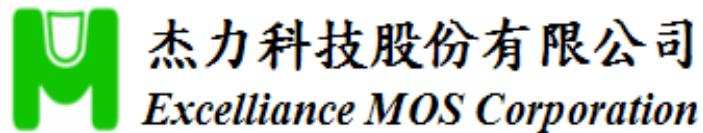
³The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz.

Copper, in a still air environment with $T_A = 25^\circ C$.

⁴Guarantee by Engineering test

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	30			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	1	1.5	3	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 20\text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 24\text{V}, V_{\text{GS}} = 0\text{V}$			1	μA
		$V_{\text{DS}} = 20\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$			25	
On-State Drain Current ¹	$I_{\text{D}(\text{ON})}$	$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 10\text{V}$	123			A
Drain-Source On-State Resistance ¹	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 10\text{V}, I_D = 25\text{A}$		1.8	2.1	$\text{m}\Omega$
		$V_{\text{GS}} = 4.5\text{V}, I_D = 15\text{A}$		2.7	3.3	
Forward Transconductance ¹	g_{fs}	$V_{\text{DS}} = 5\text{V}, I_D = 25\text{A}$		70		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 15\text{V}, f = 1\text{MHz}$		3813		pF
Output Capacitance	C_{oss}			540		
Reverse Transfer Capacitance	C_{rss}			440		
Gate Resistance	R_g	$V_{\text{GS}} = 15\text{mV}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$		1.5		Ω
Total Gate Charge ^{1,2}	$Q_g(V_{\text{GS}}=10\text{V})$	$V_{\text{DS}} = 15\text{V}, V_{\text{GS}} = 10\text{V}, I_D = 25\text{A}$		59		nC
	$Q_g(V_{\text{GS}}=4.5\text{V})$			28		
Gate-Source Charge ^{1,2}	Q_{gs}			13		
Gate-Drain Charge ^{1,2}	Q_{gd}			11		
Turn-On Delay Time ^{1,2}	$t_{\text{d}(\text{on})}$	$V_{\text{DS}} = 15\text{V}, I_D = 5\text{A}, V_{\text{GS}} = 10\text{V}, R_G = 3\Omega$		9.7		nS
Rise Time ^{1,2}	t_r			13.2		
Turn-Off Delay Time ^{1,2}	$t_{\text{d}(\text{off})}$			61.5		
Fall Time ^{1,2}	t_f			32.2		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_C = 25^\circ\text{C}$)						
Continuous Current ⁴	I_S				123	A
Pulsed Current ³	I_{SM}				400	
Forward Voltage ¹	V_{SD}	$I_F = 25\text{A}, V_{\text{GS}} = 0\text{V}$			1.2	V
Reverse Recovery Time	t_{rr}	$I_F = I_S, dI_F/dt = 100\text{A} / \mu\text{s}$		35		nS
Peak Reverse Recovery Current	$I_{\text{RM}(\text{REC})}$			200		A
Reverse Recovery Charge	Q_{rr}			25		nC



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¹Pulse test : Pulse Width \leq 300 μ sec, Duty Cycle \leq 2%.

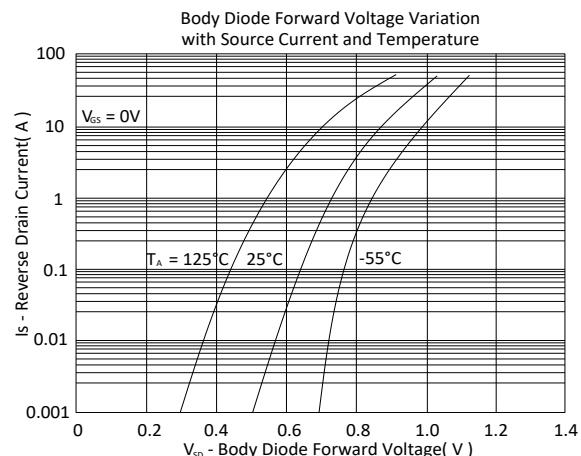
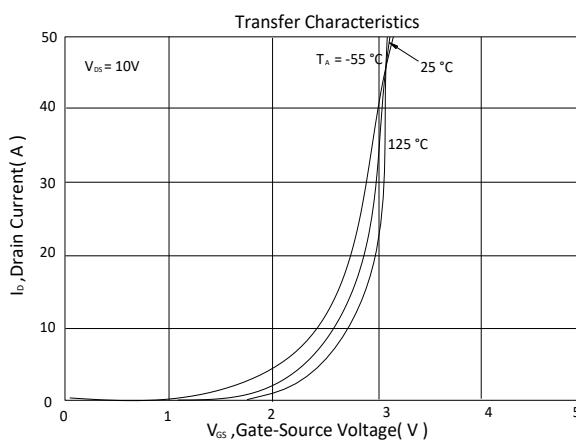
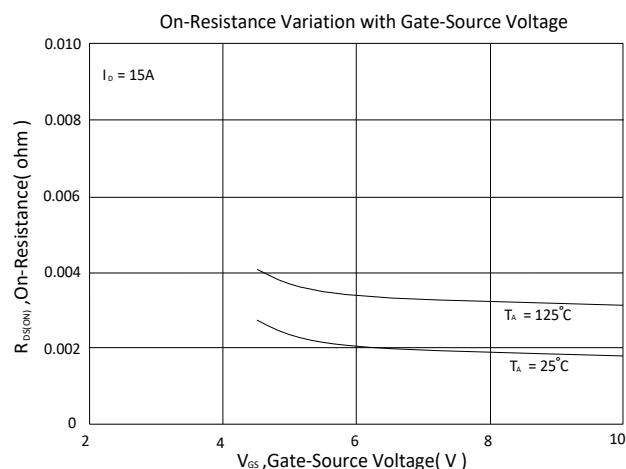
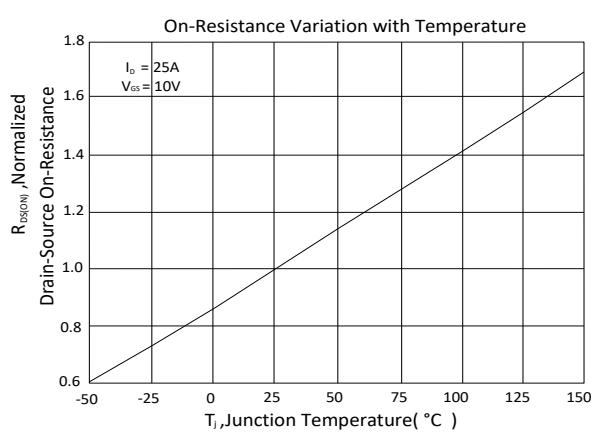
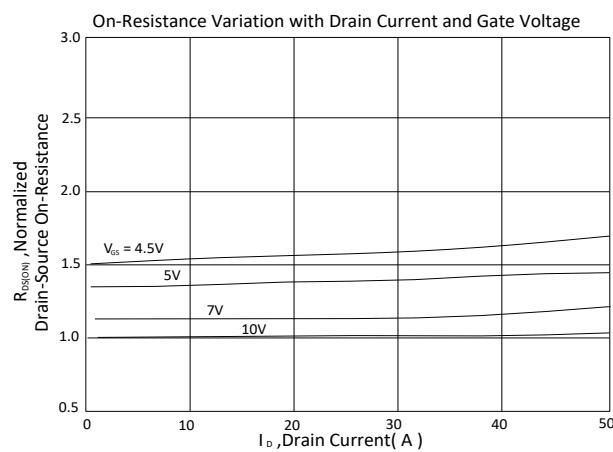
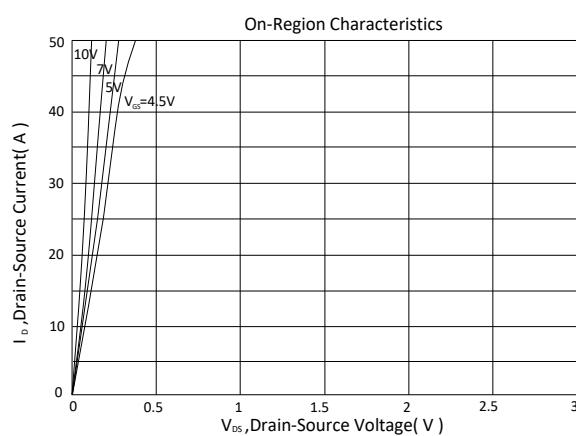
²Independent of operating temperature.

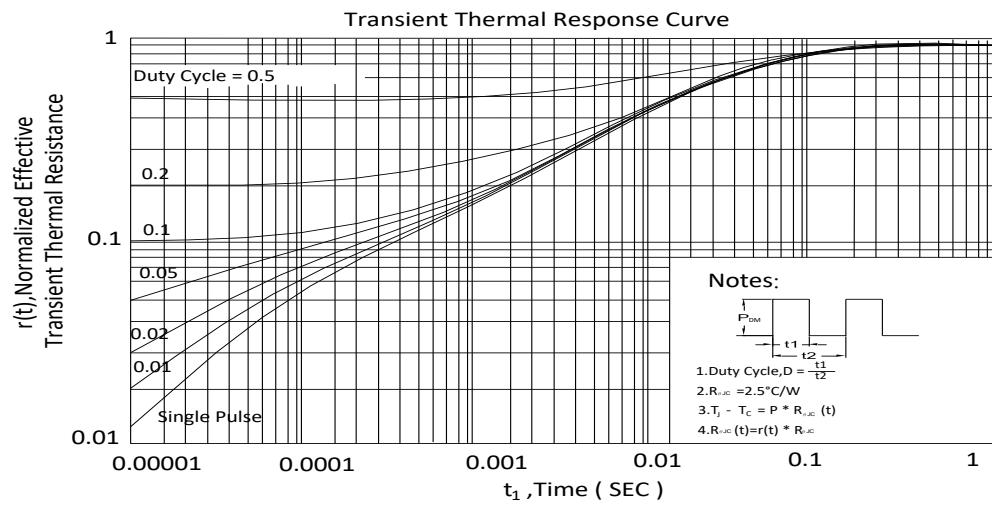
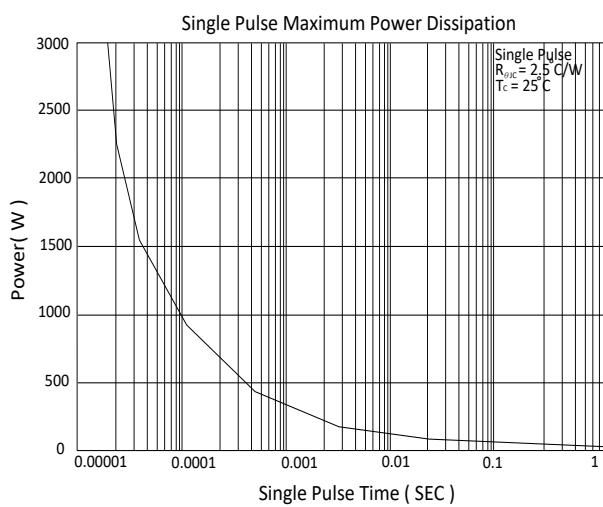
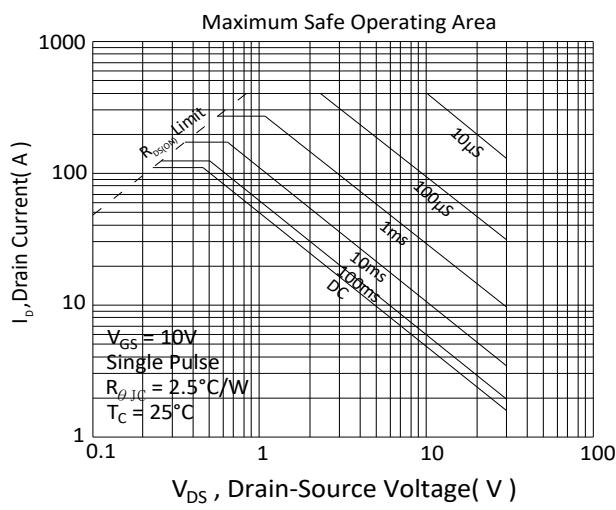
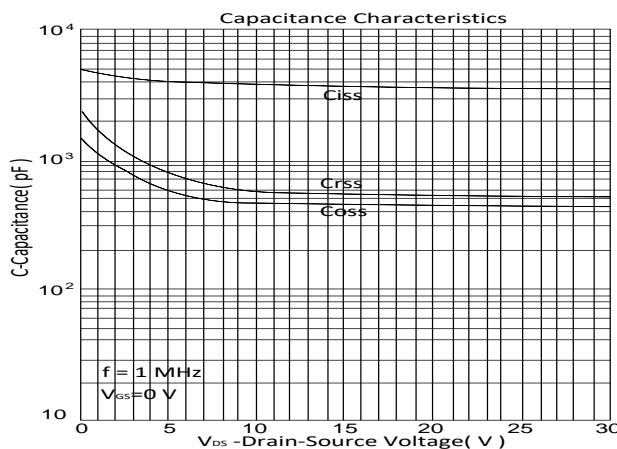
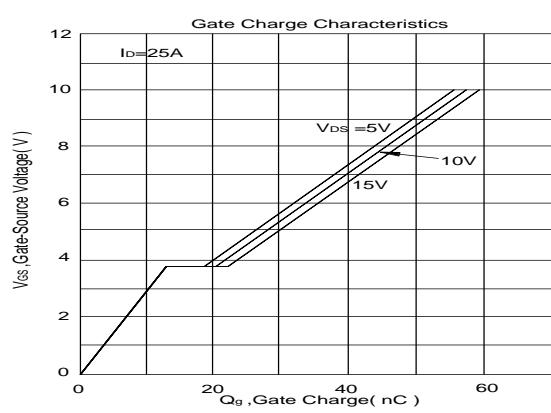
³Pulse width limited by maximum junction temperature.

⁴Package Limited.

EMC will review datasheet by quarter, and update new version.

TYPICAL CHARACTERISTICS





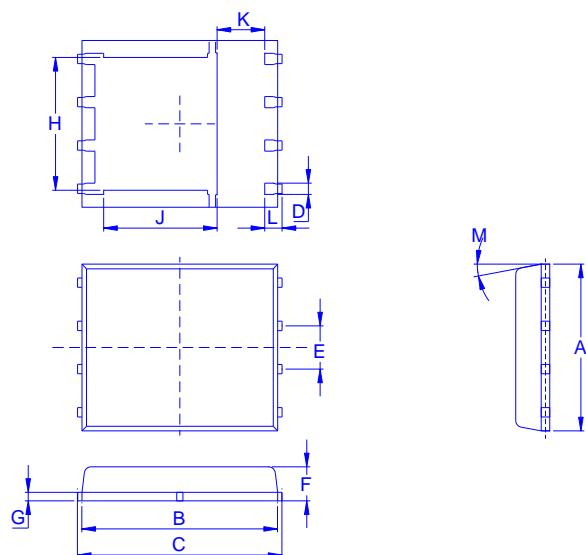
Ordering & Marking Information:

Device Name: EMP21N03HC for EDFN5X6



- EMP21N03HC: Device Name
- ABCDEFG: Date Code
- A: Assembly House
- B: Year(A:2008 B:2009 C:2010....)
- C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)
- DEFG: Serial No.

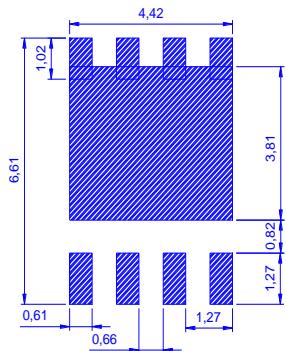
Outline Drawing



Dimension in mm

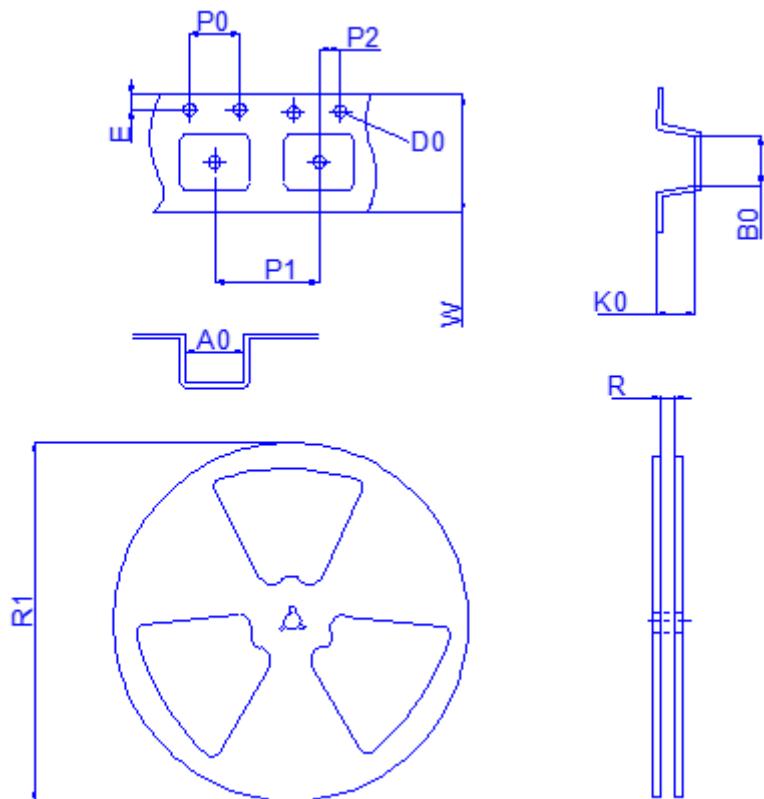
Dimension	A	B	C	D	E	F	G	H	J	K	L	M
Min	4.8	5.55	5.9	0.3	1.17	0.85	0.15	3.61	3.18	1	0.38	0°
Typ.	4.9	5.7	6	0.4	1.27	0.95	0.2	3.87	3.44	1.2	0.4	
Max	5.4	5.85	6.15	0.51	1.37	1.17	0.34	4.31	3.78	1.39	0.71	12°

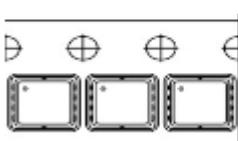
Recommended minimum pads





Tape&Reel Information:2500pcs/Reel(Dimension in millimeter)



Package	EDFN5X6
Reel	13"
Device orientation	FEED DIRECTION 

Dimension in mm

Dimension	Carrier tape								Reel		
	A0	B0	D0	E	K0	P0	P1	P2	W	R	R1
Typ.	6.4	5.3	1.5	1.8	1.6	4	8	2	12	12.4	330
±	0.2	0.2	0.1	0.1	0.6	0.1	0.1	0.1	0.3	2	2